

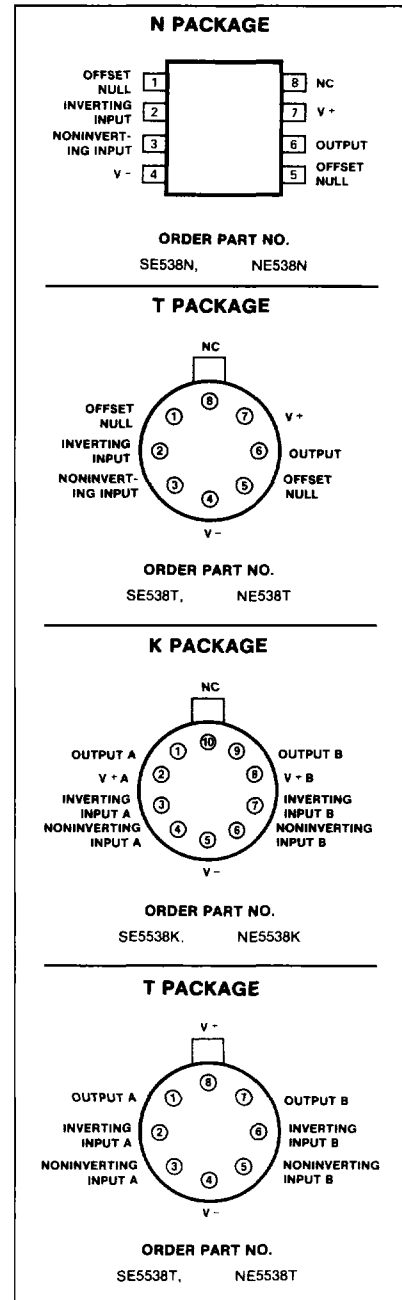
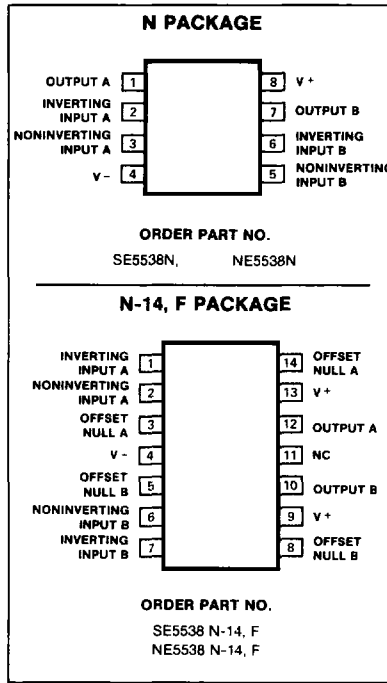
DESCRIPTION

The 538/5538 are new generation operational amplifiers featuring high slew rates combined with improved input characteristics. Internally compensated for gains of 5 or larger, the SE538/SE5538 offer guaranteed minimum slew rates of 40V/μs or larger. Featuring 2mV max input offset voltage, the 538 is a single amplifier while the 5538 is a dual version. Industry standard pin out and internal compensation allow the user to upgrade system performance by directly replacing general purpose amplifiers, such as 748, 101A, 741, 747 and 1458.

FEATURES

- 2mV max input offset voltage
- 60nA max input offset current
- Short circuit protected
- Offset null capability
- Large common mode and differential voltage ranges
- 60V/μs slew rate (gain of +5, -4 min)
- 6MHz gain bandwidth product (gain +5, -4 minimum)
- Internal frequency compensation (gain of +5, -4 minimum)
- Pin out: 538 same as 741 (single)
5538 same as 747, 1458 (dual)

PIN CONFIGURATIONS



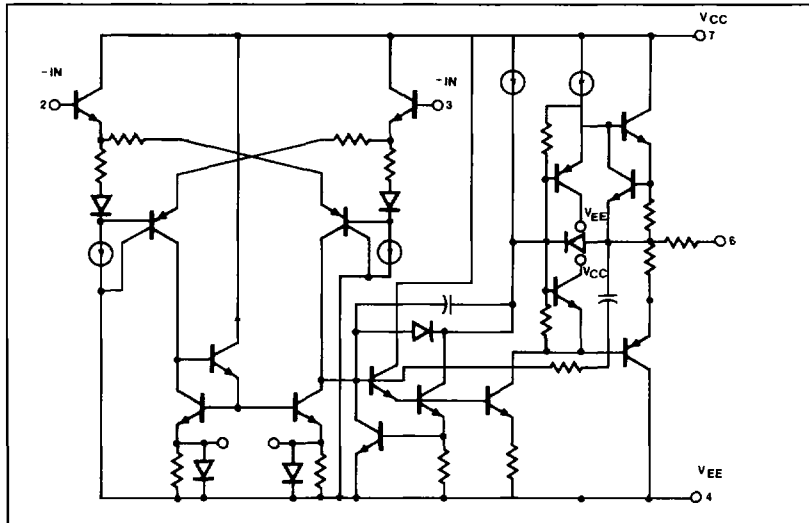
ABSOLUTE MAXIMUM RATINGS^{1,2,3}

PARAMETER	RATING	UNIT
V _{CC} Supply voltage		
SE military grade	±22	V
NE commercial grade	±18	V
P _D Internal power dissipation	1000	mW
F package		
P _D Internal power dissipation ¹	500	mW
N package		
P _D Internal power dissipation ¹	800	mW
K, T package		
Differential input voltage	±30	V
Input voltage ²	±15	V
Operating temperature range		
SE military grade	-55 to +125	°C
NE commercial grade	0 to 70	°C
Output short circuit ³	indefinite	
Storage temperature range	-65 to +150	°C
Lead temperature (solder, 60sec.)	300	°C

NOTES

1. Rating applies for thermal resistances of 240°C/W and 150°C/W junction to ambient for N and K, T packages, respectively. Maximum chip temperature is 150°C
2. For supply voltages less than ±15V, the absolute maximum input voltage is equal to the supply voltage.
3. Short circuit may be to ground or either supply. Rating applies to 125°C case temperature or 75°C ambient temperature

EQUIVALENT SCHEMATIC (EACH AMPLIFIER)



DC ELECTRICAL CHARACTERISTICS $T_A = 25^\circ\text{C}$, $V_S = \pm 15\text{V}$ unless otherwise specified.

PARAMETER	TEST CONDITIONS	SE538/SE5538			NE538/NE5538			UNIT
		Min	Typ	Max	Min	Typ	Max	
V_{os}	Input offset voltage		0.7	2.0		2.0	5.0	mV
V_{os}	Input offset voltage			3.0			6.0	mV
ΔV_{os}	Input offset voltage drift		3.0	15		6.0		$\mu\text{V}/^\circ\text{C}$
I_{os}	Input offset current		5	10		15	40	nA
I_{os}	Input offset current			20			80	nA
I_B	Input current		45	60		65	150	nA
I_B	Input current			100			200	nA
V_{CM}	Input common mode voltage range	± 12	± 13		± 12	± 13		V
CMRR	Common mode rejection ratio	70	90		70	90		dB
PSRR	Power supply rejection		30	150		30	150	$\mu\text{V}/\text{V}$
R_{IN}	Input resistance	3	10		1	6		M Ω
A_{VOL}	Large signal voltage gain	50	200		50	200		V/mV
A_{VOL}	Large signal voltage gain	25			25			V/mV
V_{OUT}	Output voltage	± 10	± 13		± 10	± 13		V
V_{OUT}	Output voltage	± 12	± 14		± 12	± 14		V
I_{CC}	Supply current		2	3		2	3	mA
I_{CC}	Supply current		2.2	3.6		2.2		mA
P_D	Power dissipation		60	90		60	90	mW
P_D	Power dissipation		66	108		66		mW
I_{SC}	Output short circuit current		25			25		mA
R_{OUT}	Output resistance		100			100		Ω

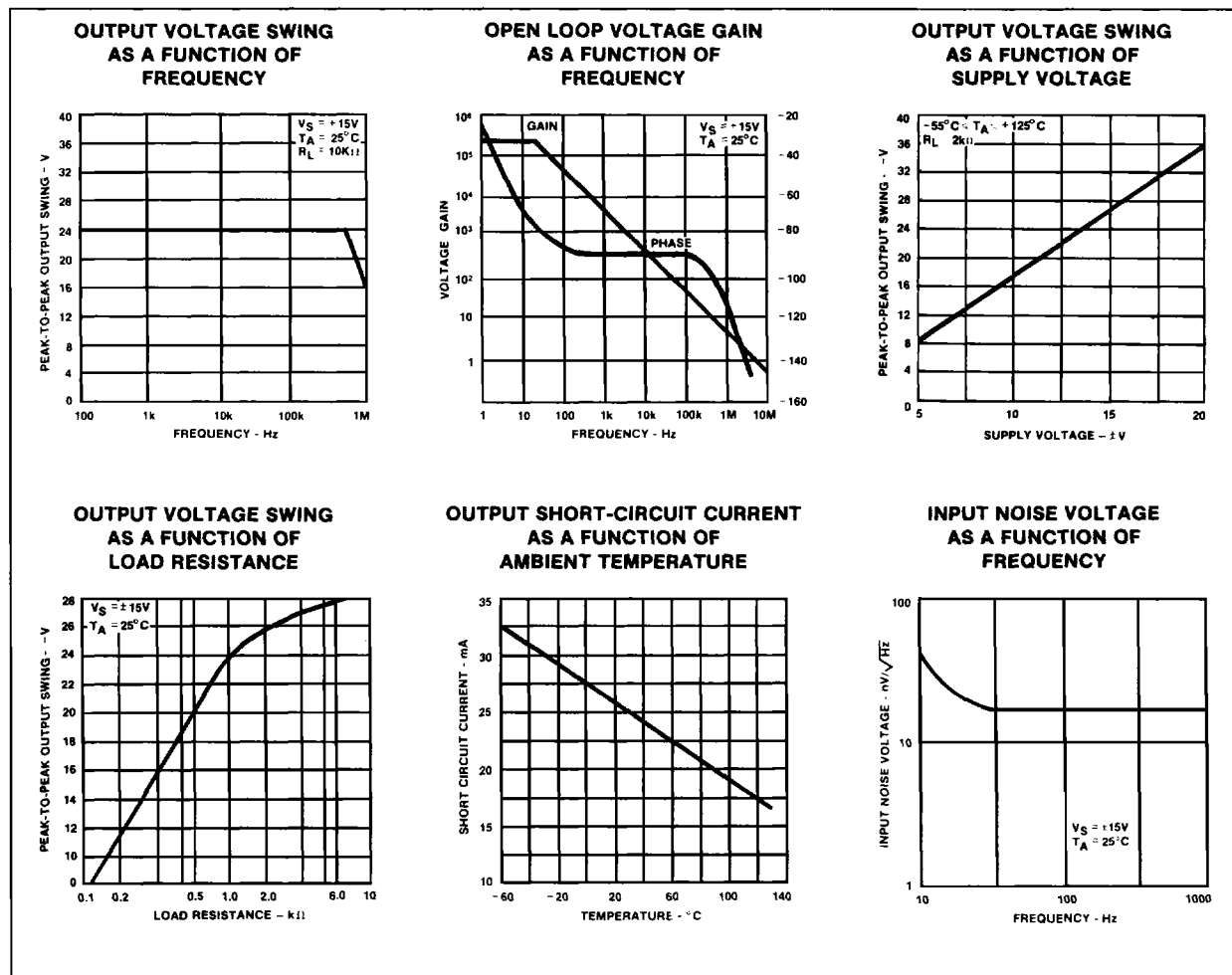
NOTE

Temperature Range
 SE Types $-55^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$
 NE Types $0^\circ\text{C} \leq T_A \leq 70^\circ\text{C}$

AC ELECTRICAL CHARACTERISTICS $T_A = 25^\circ\text{C}$ unless otherwise specified.

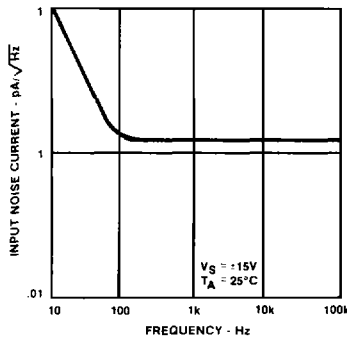
PARAMETER	TEST CONDITIONS	SE538/SE5538			NE538/NE5538			UNIT
		Min	Typ	Max	Min	Typ	Max	
Gain bandwidth product (Gain +5, -4 minimum)			6			6		MHz
Transient response Small signal rise time Small signal overshoot			0.25 6			0.25 6		μs %
Settling time	To 0.1%		1.2			1.2		μs
Slew rate	Minimum gain = 5 Noninverting $R_L \geq 2k\Omega$	40	60			60		$\text{V}/\mu\text{s}$

TYPICAL PERFORMANCE CHARACTERISTICS

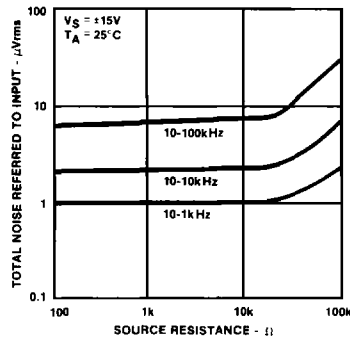


TYPICAL PERFORMANCE CHARACTERISTICS (Cont'd)

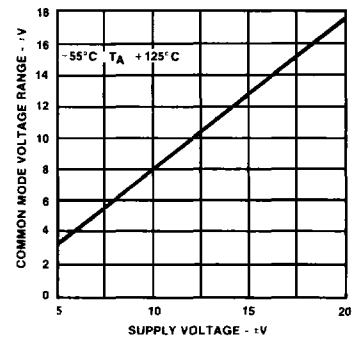
INPUT NOISE CURRENT AS A FUNCTION OF FREQUENCY



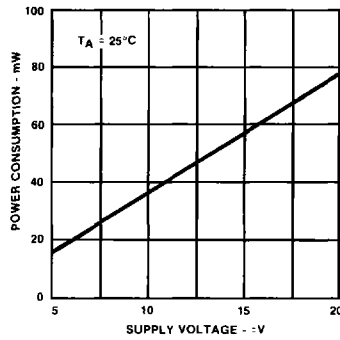
BROADBAND NOISE FOR VARIOUS BANDWIDTHS



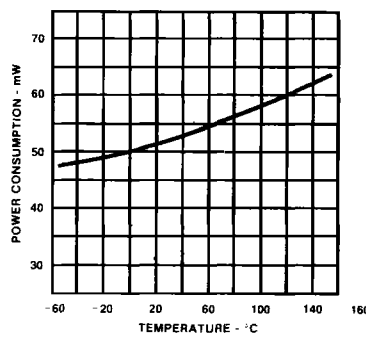
INPUT COMMON MODE VOLTAGE RANGE AS A FUNCTION OF SUPPLY VOLTAGE



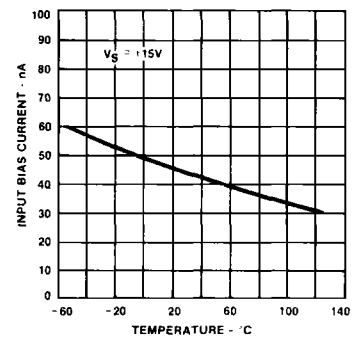
POWER CONSUMPTION AS A FUNCTION OF SUPPLY VOLTAGE



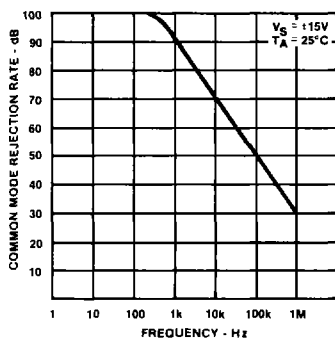
POWER CONSUMPTION AS A FUNCTION OF AMBIENT TEMPERATURE



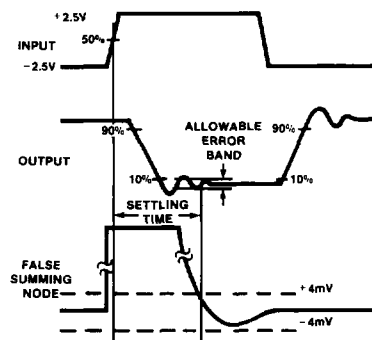
INPUT BIAS CURRENT AS A FUNCTION OF AMBIENT TEMPERATURE



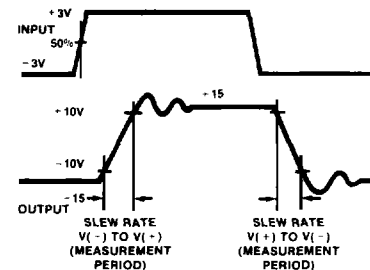
COMMON MODE REJECTION RATIO AS A FUNCTION OF FREQUENCY



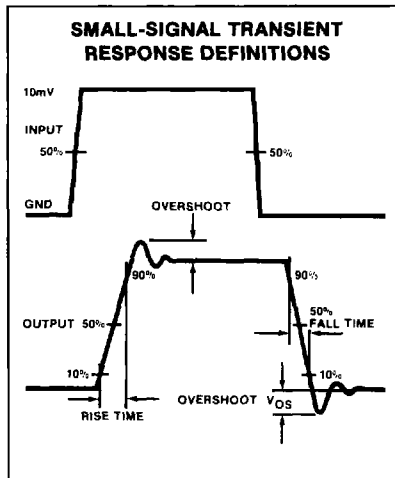
SETTLING TIME MEASUREMENT WAVEFORMS



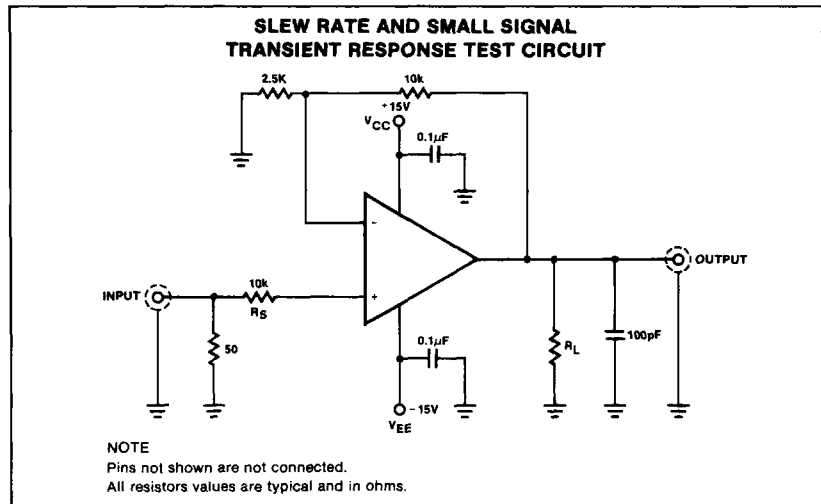
SLEW RATE MEASUREMENT VCC = ±20V



TYPICAL PERFORMANCE CHARACTERISTICS (Cont'd)



TEST LOAD CIRCUITS



TEST LOAD CIRCUITS (Cont'd)

